



Docket No.: I8363.0002/P002
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Yoav Eichen

Application No.: 09/674,090

Group Art Unit: 1637

Filed: March 1, 2001

Examiner: Jeffrey Siew

For: DETECTION OF A TARGET IN A
SAMPLE BY MEASURING
CONDUCTANCE (as amended)

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AMENDMENT

Box Fee Amendment
Commissioner for Patents
Washington, DC 20231

Dear Sir:

In response to the Office Action dated November 25, 2002 (Paper No. 20), please amend the above-identified U.S. patent application as shown in the following sections entitled "Amendment to the Specification" and "Amendments to the Claims".